
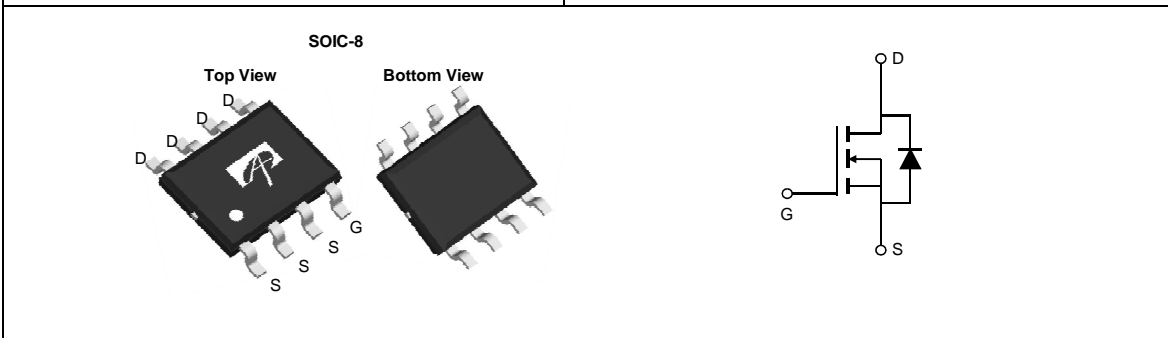


<p>General Description</p> <ul style="list-style-type: none"> Latest Trench Power AlphaMOS (αMOS LV) technology Very Low RDS(on) at 4.5V_{GS} Low Gate Charge High Current Capability RoHS and Halogen-Free Compliant <p>Application</p> <ul style="list-style-type: none"> DC/DC Converters in Computing, Servers, and POL Isolated DC/DC Converters in Telecom and Industrial 	<p>Product Summary</p> <table style="width: 100%; border: none;"> <tr> <td style="padding: 2px 10px 2px 0;">V_{DS}</td> <td style="padding: 2px 10px 2px 0;">30V</td> </tr> <tr> <td style="padding: 2px 10px 2px 0;">I_D (at $V_{GS}=10V$)</td> <td style="padding: 2px 10px 2px 0;">23A</td> </tr> <tr> <td style="padding: 2px 10px 2px 0;">$R_{DS(ON)}$ (at $V_{GS}=10V$)</td> <td style="padding: 2px 10px 2px 0;">< 3.7mΩ</td> </tr> <tr> <td style="padding: 2px 10px 2px 0;">$R_{DS(ON)}$ (at $V_{GS} = 4.5V$)</td> <td style="padding: 2px 10px 2px 0;">< 5.3mΩ</td> </tr> </table> <p>100% UIS Tested 100% R_g Tested</p> <div style="text-align: right;">  </div>	V_{DS}	30V	I_D (at $V_{GS}=10V$)	23A	$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 3.7mΩ	$R_{DS(ON)}$ (at $V_{GS} = 4.5V$)	< 5.3mΩ
V_{DS}	30V								
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Absolute Maximum Ratings $T_A=25^{\circ}C$ unless otherwise noted			
Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current	I_D	$T_A=25^{\circ}C$	23
		$T_A=100^{\circ}C$	14
Pulsed Drain Current ^C	I_{DM}	174	A
Avalanche Current ^C	I_{AS}	37	A
Avalanche energy $L=0.1mH$ ^C	E_{AS}	68	mJ
V_{DS} Spike	100ns	V_{SPIKE}	36
Power Dissipation ^B	P_D	$T_A=25^{\circ}C$	3.1
		$T_A=100^{\circ}C$	1.2
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics					
Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$t \leq 10s$	$R_{\theta JA}$	31	40	°C/W
	Steady-State		59	75	°C/W
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	16	24	°C/W

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V T _J =55°C			1 5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±20V			100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.2	1.8	2.2	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A T _J =125°C		3 4.1	3.7 5	mΩ
		V _{GS} =4.5V, I _D =20A		4.1	5.3	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A		105		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.7	1	V
I _S	Maximum Body-Diode Continuous Current				4	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance			2010		pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz		898		pF
C _{rss}	Reverse Transfer Capacitance			124		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	0.9	1.8	2.7	Ω
SWITCHING PARAMETERS						
Q _{g(10V)}	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =20A		36	49	nC
Q _{g(4.5V)}	Total Gate Charge			17	23	nC
Q _{gs}	Gate Source Charge			6		nC
Q _{gd}	Gate Drain Charge			8		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =15V, R _L =0.75Ω, R _{GEN} =3Ω		7.5		ns
t _r	Turn-On Rise Time			4.0		ns
t _{D(off)}	Turn-Off DelayTime			37.0		ns
t _f	Turn-Off Fall Time			7.5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs		14		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=500A/μs		20.3		nC

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

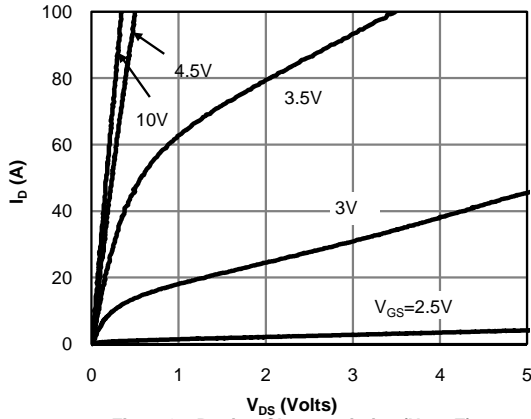


Fig 1: On-Region Characteristics (Note E)

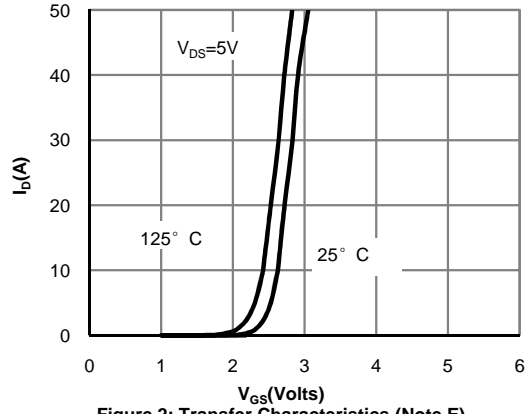


Figure 2: Transfer Characteristics (Note E)

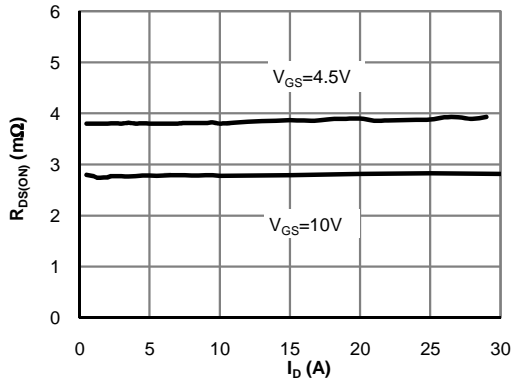


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

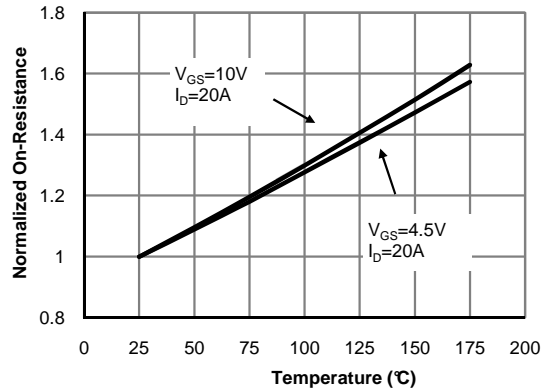


Figure 4: On-Resistance vs. Junction Temperature (Note E)

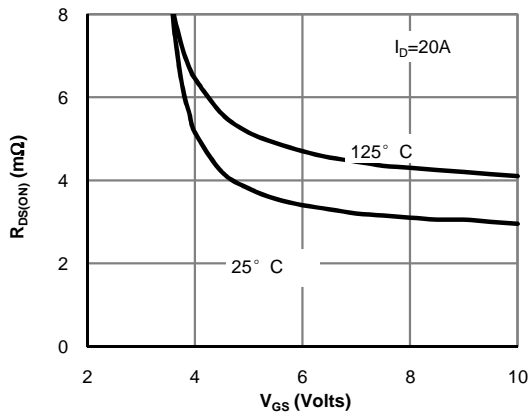


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

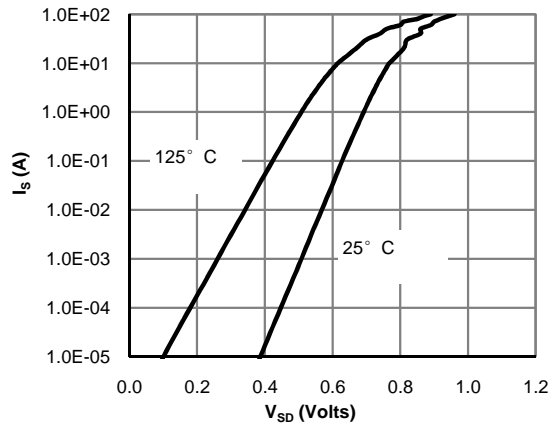


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

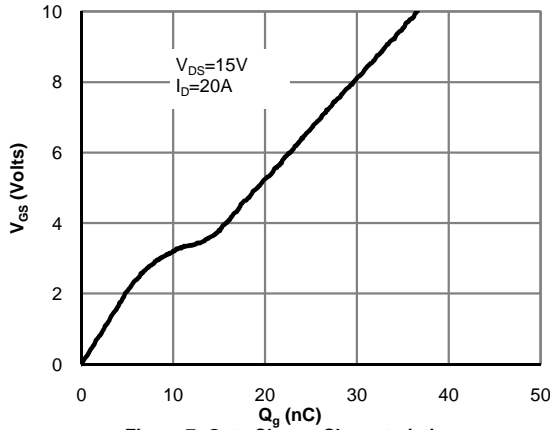


Figure 7: Gate-Charge Characteristics

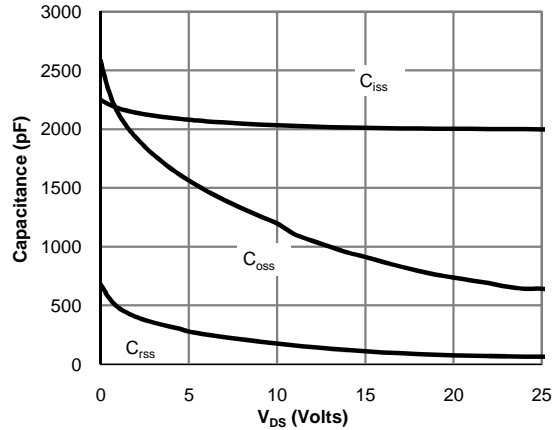


Figure 8: Capacitance Characteristics

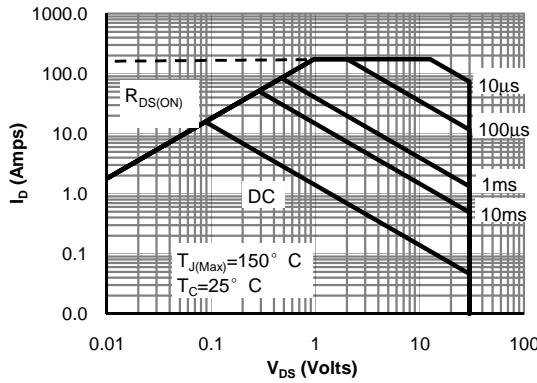


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

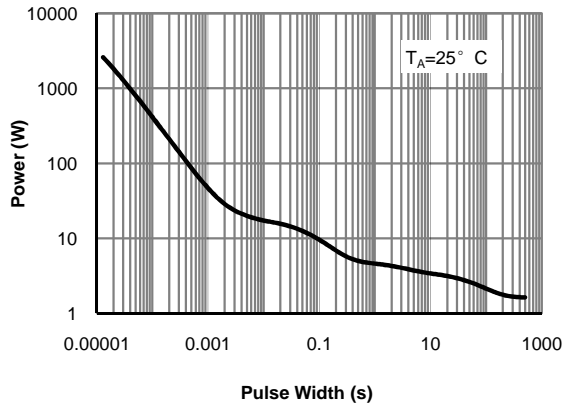


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note F)

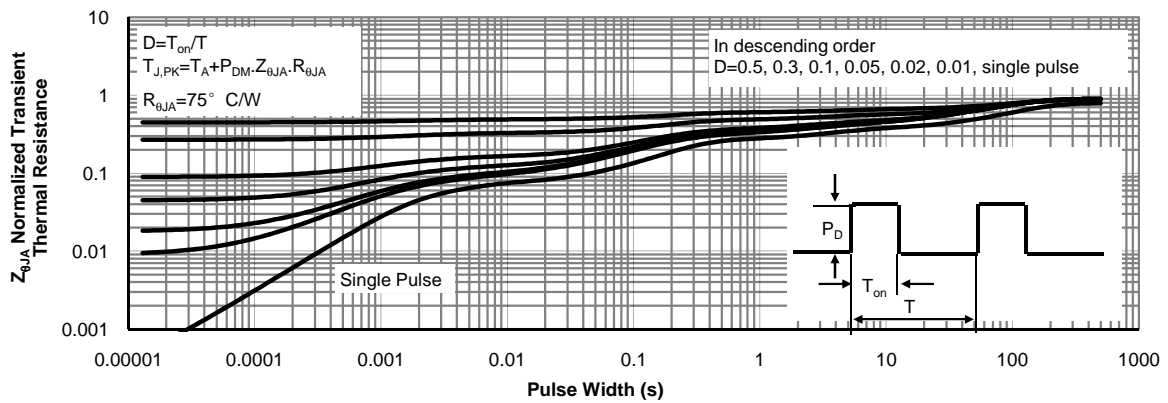
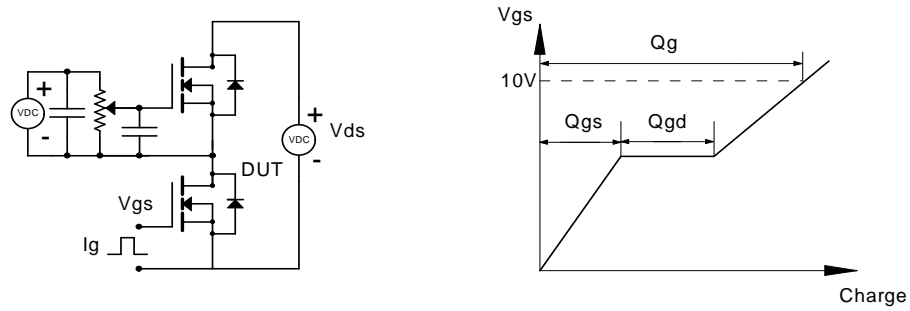
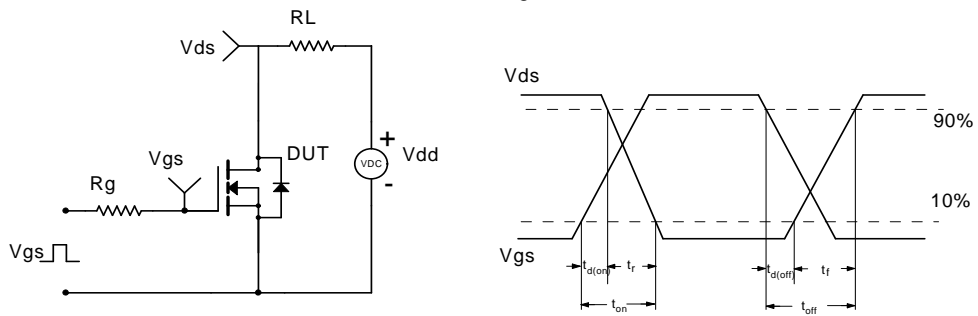


Figure 15: Normalized Maximum Transient Thermal Impedance (Note F)

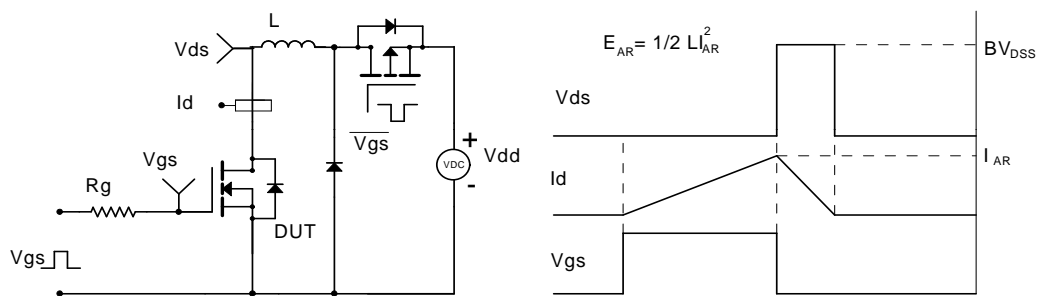
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

